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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/511,021	AHRNDT ET AL.	
Examiner	Art Unit	
Quoc D. Tran	2614	

SEARCHED				
Class	Subclass	Date	Examiner	
379	1.01	9/22/2007	QT	
	1.03			
	1.04			
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	22.01			
	22.02			
	22.07			
	23			
	24			
	29.01			
	29.03			
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEAF (INCLUDING S	RCH NOTE SEARCH S	S TRATEGY)
		DATE	EXMR
EAST		9/22/2007	QT